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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/827,202	04/19/2004	Olubunmi O. Adetutu	SC13238TP	2319
23125 75	90 09/22/2005		EXAM	INER
	SEMICONDUCTO	EVERHART, CARIDAD		
LAW DEPART 7700 WEST PA	MENT ARMER LANE MD:TX	K32/PL02	ART UNIT	PAPER NUMBER
AUSTIN, TX			2891	

DATE MAILED: 09/22/2005

Please find below and/or attached an Office communication concerning this application or proceeding.

		Application No.	Applicant(s)			
Office Action Summary		10/827,202	ADETUTU ET AL.			
		Examiner	Art Unit			
		Caridad M. Everhart	2891			
Period fo	- The MAILING DATE of this communication app	ears on the cover sheet with the	correspondence address			
A SHO WHIC - Exten after: - If NO - Failur	DRTENED STATUTORY PERIOD FOR REPLY HEVER IS LONGER, FROM THE MAILING DASIONS of time may be available under the provisions of 37 CFR 1.13 SIX (6) MONTHS from the mailing date of this communication. period for reply is specified above, the maximum statutory period verone to reply within the set or extended period for reply will, by statute eply received by the Office later than three months after the mailing datent term adjustment. See 37 CFR 1.704(b).	ATE OF THIS COMMUNICATION 36(a). In no event, however, may a reply be tivill apply and will expire SIX (6) MONTHS from the application to become ABANDON	nthe mailing date of this communication. ED (35 U.S.C. § 133).			
Status						
1\⊠	Responsive to communication(s) filed on <u>08 Ju</u>	uly 2005.				
•	This action is FINAL . 2b)⊠ This action is non-final.					
3)	Since this application is in condition for allowance except for formal matters, prosecution as to the merits is					
٠,١	closed in accordance with the practice under Ex parte Quayle, 1935 C.D. 11, 453 O.G. 213.					
Dispositi	on of Claims					
4)⊠	4)⊠ Claim(s) <u>1-39</u> is/are pending in the application.					
·, _	4a) Of the above claim(s) is/are withdrawn from consideration.					
	Claim(s) 29-39 is/are allowed.		•			
	6)⊠ Claim(s) <u>1-4 and 23-28</u> is/are rejected.					
	7)⊠ Claim(s) <u>5-22</u> is/are objected to.					
8)	Claim(s) are subject to restriction and/o	or election requirement.				
	ion Papers					
	The specification is objected to by the Examine	er.				
10) The drawing(s) filed on is/are: a) accepted or b) objected to by the Examiner.						
10)[Applicant may not request that any objection to the	drawing(s) be held in abeyance.	see 37 CFR 1.85(a).			
	Replacement drawing sheet(s) including the correct	ation is required if the drawing(s) is	objected to. See 37 CFR 1.121(d).			
441	The oath or declaration is objected to by the E	yaminer Note the attached Office	ce Action or form PTO-152.			
11)[The bath of declaration is objected to by the E	Administration and analysis and				
-	under 35 U.S.C. § 119		(a)-(d) or (f)			
a)	Acknowledgment is made of a claim for foreign All b) Some * c) None of: 1. Certified copies of the priority documents. Certified copies of the priority documents. Copies of the certified copies of the priority documents. Copies of the certified copies of the priority documents. Copies of the certified copies of the priority documents. Copies of the certified copies of the priority documents. Copies of the certified copies of the priority documents. Copies of the certified copies of the priority documents. Copies of the certified copies of the priority documents. Copies of the certified copies of the priority documents. Copies of the certified copies of the priority documents. Copies of the certified copies of the priority documents. Copies of the priority documents. Copies of the certified copies of the priority documents. Copies of the priori	nts have been received. Its have been received in Applic Ority documents have been rece au (PCT Rule 17.2(a)).	ation No ived in this National Stage			
2) Not	nt(s) ice of References Cited (PTO-892) ice of Draftsperson's Patent Drawing Review (PTO-948) ormation Disclosure Statement(s) (PTO-1449 or PTO/SB/0) over No(s)/Mail Date 7-22-05.	4) Interview Summ Paper No(s)/Mai 5) Notice of Inform 6) Other:				

Claim Rejections - 35 USC § 103

The text of those sections of Title 35, U.S. Code not included in this action can be found in a prior Office action.

Claims 1-4, 23, 24, and 26-28 are rejected under 35 U.S.C. 103(a) as being unpatentable over Chen, et al. (US 2004/0198009A1) in view of Arai(JP63-299280A)(abstract).

Chen, et al disclose the steps of forming a gate metal on a first gate dielectric portion of a substrate (in which the layer 16 is the gate oxide, layer 46 is conductive layer and layer 44 is tungsten (paragraph 0052, and 0056 and Fig. 11), while the gate dielectric in a second portion of the substrate is protected by layer 18 shown in Fig. 11, which is interpreted as selectively forming the conductor on the first portion of the gate dielectric on the substrate. Chen, et al further teach that one portion is NMOS and the other is PMOS (paragraph 0053). Layer 38 shown in Fig. 13 is a different metal from that in the first gate (paragraph 0063). The first metal layer can be deposited by CVD (paragraphs 0055 and 0056). Although Chen, et al teach a polysilicon layer and a silicide as the first conductive layer, this is not excluded by the claims, as claim 27 includes the deposition of polysilicon and metal layers. The metals in the first and second gates have different work function, as the metals are different metals.

Chen et al teaches polysilicon as the first conductor rather than metal.

Arai teaches depositing silicide and refractory metal as the conductive layers, and in applicant's specification, as mentioned in applicant's response, silicide is included in the deposition of metal.

It would have been obvious to one of ordinary skill in the art at the time of the invention to have used the process taught by Chen et al for the deposition of metal as taught by Arai because Arai teaches that multiple gates of different layers can be formed for different parts of a substrate and the process taught by Chen et al is an improvement of this method.

Claim 25 is rejected under 35 U.S.C. 103(a) as being unpatentable over Chen et al in view of Arai as applied to claim 1 above, and further in view of Forbes, et al. (US 2004/0140513A1).

Chen et al does not teach ALD.

Forbes et al teaches ALD for the deposition of layers in the formation of gates of different work functions(paragraph 0019 and 0032).

It would have been obvious to one of ordinary skill in the art at the time of the invention to have applied the method taught by Forbes et al to the process taught by Chen et al in view of Arai because Chen et al teaches many of the same materials as does Forbes et al for the same purpose, that is the formation of gates of different work functions, and because Forbes et al teaches that ALD is a modification of CVD(paragraph 0021), which is taught by Chen et al.

Allowable Subject Matter

Art Unit: 2891

Claims 29-39 are allowed.

Claims 5-22 are objected to as being dependent upon a rejected base claim, but would be allowable if rewritten in independent form including all of the limitations of the base claim and any intervening claims.

The prior art of record does not teach the limitation "forming an inhibitor on the gate dielectric of the second region".

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Caridad M. Everhart whose telephone number is 571-272-1892. The examiner can normally be reached on Monday through Fridays 7:30-4:00.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, B. Baumeister can be reached on 571-272-1722. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

C. Everhart 9-19-05